

Search Notes



Application/Control No.

10/074,304

Examiner

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Applicant(s)/Patent under Reexamination

SHEPARD ET AL.

Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner
710	1-4, 8-14, 20-21, 62-63	6-10-05	CS
710	72, 104		
709	208,220		
713	100		
700	2-12, 20		
712	1-15		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
710	8, 104	6-11-05	CS
700	2,8		
712	10		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
PLUS	6-10-05	CS
INVENTOR SEARCHED	6-10-05	CS
EAST (USPGPUB, EPO, JPO, USPAT, DERWENT, IBM_TDB, USOCR)	6-10-05	CS